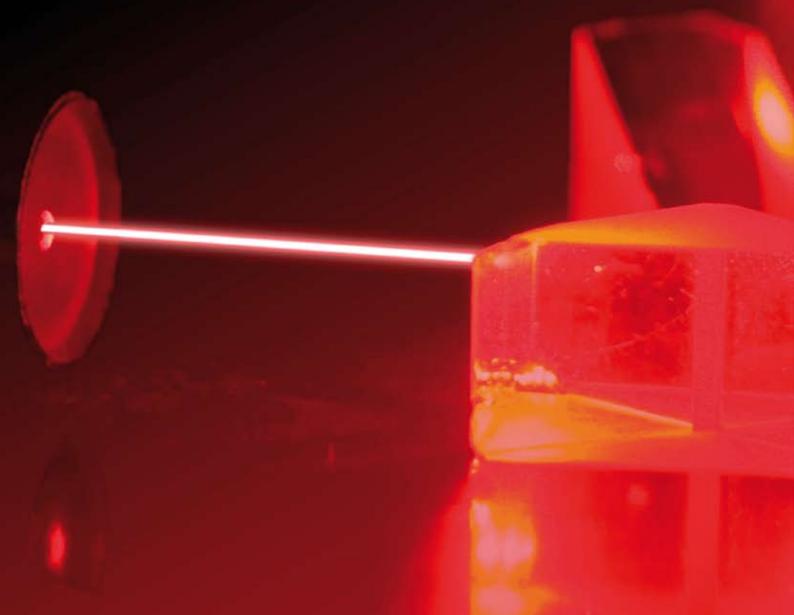


Special materials for Precision Optics & Laser Coatings

Oxides for Evaporation



Titanium oxides

- > Highest refractive index of oxides in visible range
- AR and multilayer coatings on glass and polymers
- > Best reproducibility by using Ti₃O₅
- > Stable evaporation behaviour without spitting or outgassing
- > High UV-blockage and low thermal substrate load for coatings on plastics

Film properties

Refractive index at 550 nm > on unheated substrates/no IAD > on heated substrates, $T_s = 250 \, ^{\circ}\text{C/no IAD}$ > on unheated substrates/with IAD Range of transparency (fully oxidized film) Environmental Stability 2.07 - 2.22 2.25 - 2.40 2.10 - 2.50 $400 \, \text{nm} - 11 \, \text{µm}$ $400 \, \text{lm} - 11 \, \text{µm}$

Stress

on unheated substrates/no IAD
Tensile
on heated substrates, T₅ ≥ 250 °C/no IAD
Tensile
Tensile

on unheated substrates/with IAD

Type and magnitude depending on IAD parameters

Data based on TiO₂ coatings deposited from Ti₃O₅ starting material.

Low-absorbing films deposited from all titanium oxide starting compositions are of the composition TiO_2 . The structure of the TiO_2 films depends on the deposition conditions and starting materials ranging from amorphous to crystalline anatase or rutile. This explains the wide spread in the refractive index values. TiO_2 films have the highest and most widely tunable refractive index in the visible range of all oxides with the best optical contrast to SiO_2 . TiO_2 films effectively block UV-radiation for wavelengths < 400 nm which can be used for the protection of coated polymeric substrates. The stress of TiO_2 films can be tuned in a wide range of tensile and compressive values. The compensation of the SiO_2 compressive stress for common deposition conditions along with the high index contrast favours the use of TiO_2 films in AR and multilayer coatings with a minimum number of layers. Using Ti_2O_3 starting material, thermal stresses on polymers can be reduced making this material additionally an ideal choice for coatings on plastic substrates.

Application Guidelines

Characteristics of starting material

Chemical formula	TiO	Ti_2O_3	Ti ₃ O ₅	TiO _{2-X} , TiO ₂	Ti metal
Color	Gold	Purple	Black-purple	Black, white	Grey
Density g/cm³	4.9	4.6	4.6	4.2	4.5
Melting point °C	1750	~ 1760	~ 1760	1775	1668
Delivery form	Tablets,	granulate			On request

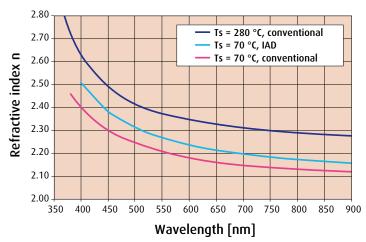
Evaporation technique

All titanium oxides melt completely. Only the Ti₃O₅ melt evaporates congruently. Titanium oxides are deposited reactively by electron beam evaporation with a Cu-crucible and Mo-liner or from W-boats.

Typical deposition in all sizes of coating systems involves rates of 0.2-0.5 nm/s at 0_2 pressures of $2-3 \times 10^{-4}$ mbar (or equivalent 0_2 flow). For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed. 0_2 -operated RF plasma ion sources are able to produce high-dense TiO₂ films with full stress compensation relative to SiO₂.

Application fields

AR and multilayer coatings (dielectric mirrors, dichroics, narrowband filters, polarizers, beamsplitters) for VIS and IR spectral range, coatings for precision optics and on plastics, to a lesser extent for laser coatings.



Typical dispersion of the refractive index for the indicated deposition conditions.

DRALOTM

- > Reduced refractive index compared to pure TiO₂ enabling a higher AR bandwidth
- > Effective protection against UV radiation
- > Widely tunable film stress from tensile to compressive values
- Reduced structural film stress compared to pure TiO₂
- > Optimized thermal film stress on plastics compared to pure TiO₂
- › Very good thickness homogeneity and run-to-run stability
- > Excellent environmental durability
- > Very good resistance against combined attack of heat, humidity and UV-radiation
- Controlled water barrier

Film properties

Refractive index at 550 nm

> on unheated substrates/no IAD 2.04 - 2.18> on heated substrates, $T_s \ge 250$ °C/no IAD 2.26 - 2.28> on unheated substrates/with IAD 2.05 - 2.30

on unheated substrates/with IAD

Range of transparency (fully oxidized film)

400 nm - 7.0 μm

Environmental Stability

MIL-C-675 B/C passed

Stress

on unheated substrates/no IAD

Mostly tensile depending on rate and O₂ pressure

• on heated substrates, $T_s \ge 250 \, ^{\circ}\text{C/no IAD}$

no IAD Tensile

on unheated substrates/with IAD

Type depending on IAD

parameters

These properties make $DRALO^{TM}$ layers especially well-suited as the high-index material in precision optics.

Application Guidelines

Characteristics of starting material

Chemical formula Ti-Al-oxide Color Black metallic

Density g/cm³ 4.5
Melting point °C 1700
Delivery form Granulate

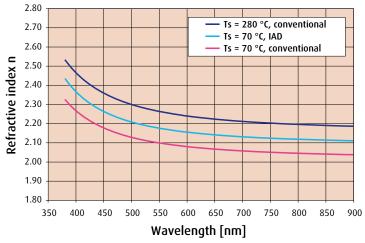
Evaporation technique

DRALOTM films can be produced by reactive electron beam evaporation using Cu-crucibles with Mo-liners. Typical deposition in all sizes of coating systems involves O_2 pressures of ~3 x 10^{-4} mbar (or equivalent O_2 flow) and rates 0.2-0.4 nm/s. The intended values of refractive index and film stress can be obtained by variation of substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance.

Using DRALO™ instead of pure titanium oxides requires to follow some particular guidelines to obtain reproducible, well-homogeneous films.

Application fields

AR and multilayer coatings in precision optics.



Typical dispersion of the refractive index of DRALO™ films for the indicated deposition conditions. IAD parameters for coatings on plastic substrates.

Niobium oxides

- > High refractive index oxide material for AR and multilayer coatings
- > High-temperature resistant films

Film properties

Refractive index at 550 nm

on unheated substrates/with IAD 2.27 - 2.31 on heated substrates, $T_s \ge 300$ °C 2.29 - 2.33

Range of transparency 380 nm – 8.0 μ m

Environmental Stability MIL-C-675 B/C passed

Stress

on unheated substrates/with IAD Tunable type and magnitude

on heated substrates, T_s ≥ 300 °C
Tensil

Thin films made from Nb₂O_{5x} source material have a refractive index in the range of 2.27 – 2.33 at 550 nm and a low absorbance over the whole VIS and near-IR region for a suitable deposition process or post-depositon procedure. This makes Nb₂O₅ layers especially well-suited as H-index materials in AR coatings and filters.

The excellent thermal and long-term stability of films deposited at high substrate temperatures or with plasma ion assistance make this material furthermore a good choice for thermally loaded optical applications such as heat protection filters and lighting (e.g. cold light mirrors).

The exact characteristics of individual films depend on the respective evaporation conditions such as substrate temperature, oxygen pressure, deposition rate, possibly ion assistance parameters.

Application Guidelines

Characteristics of starting material

Availability as niobium pentoxide with a minor deficiency x of oxygen $\text{Nb}_2\text{O}_{sx}.$

Evaporation technique

 Nb_2O_{sx} source material has an excellent melting and evaporation behaviour without spitting or outgassing.

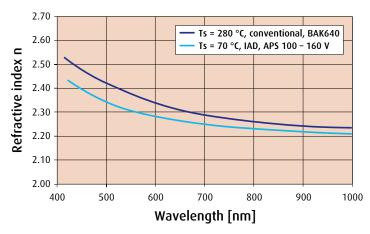
 Nb_2O_5 films can be produced from $Nb_2O_{5\times}$ granulate or disks by reactive e-beam evaporation. For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Low-absorbance films can be obtained either at low substrate temperatures with a post-deposition thermal treatment or by plasma or ion assistance or for substrate temperatures > 300 °C with oxygen pressures of $2.0-6.0 \times 10^{-4}$ mbar or equivalent flow.

Typical deposition in all sizes of coating systems involves rates 0.2 – 0.7 nm/s.

Application fields

AR and multilayer coatings (dielectric mirrors, heat protection filters, dichroics, narrowband filters, polarizers, beamsplitters) for VIS to IR spectral range. Occasional use in pure or mixed form for electrochromic coatings.



Typical dispersion of the refractive index for the indicated deposition conditions.

Tantalum oxides

- › High refractive index material with high laser damage resistance
- > Hard and durable films
- Moisture blocking and increased climate resistance
- Lithographically structurable films

Film properties

Refractive index at 550 nm

on unheated substrates/with IAD (0,) 2.07 - 2.172.07 - 2.18 on unheated substrates/with IAD (Ar+O₂) on heated substrates, T_s = 300 °C 2.12 - 2.13 Range of transparency 300 nm - 10 μm MIL-C-675 B/C passed **Environmental Stability**

Stress

on unheated substrates/with IAD (02)

Compressive on unheated substrates/with IAD (Ar+O₂) Tunable type and magnitude > on heated substrates, T_s ≥ 300 °C Tensile

Low-absorbing films deposited in appropriate conditions from all tantalum oxide starting compositions are of the composition Ta₂O₅. They have refractive indices ~ 2.07 - 2.18 in the visible range. The obtainable transparency in the near infrared spectral range is superior to titanium oxides and therefore enables the Ta₂O₅ films for laser and bandpass coatings in this range.

Film stress of transparent Ta₂O₅ films can be tuned between compressive and tensile type. Due to a reduced thermal radiation from the melt of tantalum oxides, thermal stresses on polymers can be reduced using Ta₂O₅.

Tantalum oxide films are hard, durable and among the oxides with a high laser damage threshold. They block effectively moisture and can be structured lithographically.

Application Guidelines

Characteristics of starting material

Availability as Ta₂O₅, Ta₂O_{5-x} with minor deficiency x of oxygen or RENA TaO_y.

Chemical formula	Ta₂O₅	Ta_2O_{5-x}	RENA TaO _v
Color	White	Grey-black	Dark grey – metallic
Density	8.3	~ 8.3	8.8
Melting point °C	1880	< 1880	< 1880
Delivery form	Tablets, granulate, discs		

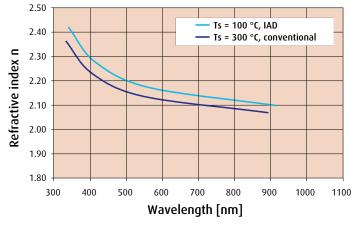
Evaporation technique

Tantalum oxides are commonly evaporated by reactive e-beam evaporation from a Cu-crucible or with Mo-liner. For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed. To obtain low-absorbing Ta₂O₅ films, it is indispensable to use strong ion assistance and/or high substrate temperature or post-deposition annealing in air. Also, the oxygen partial pressure has to be properly adjusted for deposition of the Ta₂O₅ films and their adjacent layers to avoid oxygen deficiency and absorption.

Deposition occurs typically at 0, pressures of 3 – 6 x 10⁻⁴ mbar (or equivalent O₂ flow). Typical deposition in all sizes of coating systems involves rates 0.2 - 0.7 nm/s.

Application fields

AR and multilayer coatings (dielectric mirrors, dichroics, narrowband filters, polarizers, beamsplitters) for near UV (> 300 nm), VIS and IR spectral range for precision optics and laser coatings. Special use for DWDM filters in telecommunications and for lithographically structured coating applications. Due to relative low thermal radiation from melt and humidity resistance use for coatings on plastics.



Typical dispersion of the refractive index for the indicated deposition conditions.

Zirconium oxides

- > Very hard and durable films
- High laser damage resistance
- > High refractive index material for multilayer and AR coatings on glass and plastics
- > IrO starting material with higher density and complete melting for easier evaporation

Film properties

Refractive index at 550 nm

> on unheated substrates/no IAD
> on unheated substrates/with IAD
> on heated substrates, T_s = 300 °C

Range of transparency

1.92 - 1.97
1.95 - 2.05
2.00 - 2.07

230 nm - 7.0 µm

Environmental Stability

MIL-C-675 B/C passed

Stress

> without IAD
Tensil

on unheated substrates/with IAD

Tunable type and magnitude

Regardless of the starting material composition, low-absorbing zirconia films are of the composition ZrO_2 . Such films are very hard and durable and they have a high laser damage resistance. Fully oxidized ZrO_2 films can be deposited with an optical transparency down to 230 nm and adhere well to glass, many oxides, some polymers and to metals like aluminium and silver. Due to their resistance to flexing (bending) zirconia films can be employed for coatings on plastic web. In AR coatings they can be used – partly along with thin layers of TiO_2 – to adjust the reflection characteristic.

Application Guidelines

Characteristics of starting material

Available as zirconium dioxide ZrO_z (with or without minor deficiency x of oxygen) or zirconium monoxide ZrO.

Chemical formula	ZrO ₂	ZrO _{2-X}	ZrO	Zr metal
Color	White	Grey-black	Dark grey – black	Silver metallic
Density	5.6	5.6	6.4	6.5
Melting point °C	~ 2700	~ 2700	~ 2200	1852
Delivery form	Tablets, gra	ınulate		On request

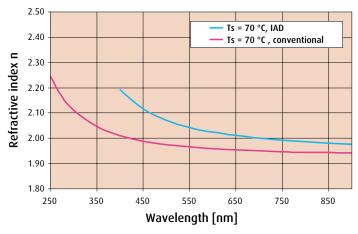
Evaporation technique

Zirconium oxides are mostly evaporated by reactive e-beam evaporation from a Cu-crucible with Mo-liner. Zirconium dioxide ${\rm ZrO}_2$ melts only superficially and predominantly sublimes. Therefore it requires a very uniform beam pattern to avoid craters and uniformity problems. ZrO is fully melting and can be used to prevent such problems. It can also be evaporated from W-boat. For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Deposition occurs typically at O_2 pressures of $1-3 \times 10^{-4}$ mbar (or equivalent O_2 flow) for ZrO_2/ZrO_{2x} and $2-3 \times 10^{-4}$ mbar (or equivalent O_2 flow) for ZrO. Typical deposition in all sizes of coating systems involves rates 0.2-0.5 nm/s. The tendency to heterogeneity can be counteracted using IAD.

Application fields

AR and multilayer coatings (laser mirrors, dichroics, narrowband filters, polarizers, beamsplitters) for DUV (> 230 nm, excimer lasers), VIS and IR spectral range for precision optics and laser coatings. Use for coatings on plastics, potentially on flexible substrates.



Typical dispersion of the refractive index for the indicated deposition conditions.

Hafnium oxides

- > High refractive index films for AR and multilayer coatings
- > Low-absorbing, hard, adherent and abrasion-resistant films
- › High laser damage threshold

Film properties

Refractive index at 550 nm

> on unheated substrates/no IAD 1.90 – 2.00 > on unheated substrates/with IAD 1.97 – 2.02 > on heated substrates, $T_s = 300 \, ^{\circ}\text{C}$ 2.04 – 2.07

Range of transparency 230 nm – ca. 8.0 µm
Environmental Stability MIL-C-675 B/C passed

Stress

on unheated substrates/no IAD Tensile

> on unheated substrates/with IAD Tunable type and magnitude on heated substrates, $T_s \ge 300 \, ^{\circ} C$ Tunable type and magnitude

Thin films made from HfO_2 or $HfO_{2\times}$ source material have a refractive index in the range of 1.90-2.07 at 550 nm and a wide spectral range of transparency extending from the near-UV to the near-IR spectral ranges. HfO_2 films deposited at high substrate temperatures or with plasma/ion assistance and/or post-deposition annealing are very low-absorbing and stable against environmental impact and high-energetic laser radiation.

These properties make HfO₂ layers especially well-suited as the high-index material in AR coatings, filters and other dielectric coatings especially for laser components.

Application Guidelines

Characteristics of starting material

Availability as hafnium dioxide HfO_2 or HfO_{2x} (with minor deficiency x of oxygen).

Chemical formula HfO_2 with traces of ZrO_2 HfO_{2x} with traces of ZrO_{2x} Color White Grey-black metallic

Density g/cm³ 9.7 9.7 Melting point °C ~ 2812 ~ 2812

Delivery form Tablets, granulate, discs

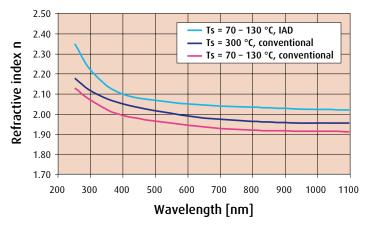
Evaporation technique

 HfO_2 films can be produced from HfO_2 or HfO_{2x} source material by reactive electron beam evaporation using Mo-crucibles/liners and prefentially rotation of the source. Due to the high melting point, the source material mostly sublimes during evaporization.

For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed. Homogeneous and low-absorbing films with highest stability, optical index and widest spectral range of transparency can be obtained at high substrate temperatures (TS ~ 280 – $300\,^{\circ}\text{C})$ or on unheated substrates using plasma or ion assistance and O_2 pressures $1-2\times10^{-4}$ mbar. Typical deposition in all sizes of coating systems involves rates 0.2 – 0.5 nm/s.

Application fields

AR and multilayer coatings (laser mirrors, dielectric mirrors, polarizers, beamsplitters) for UV (> 240 nm), VIS and IR spectral range for precision optics and laser coatings. Protective coating for metal mirror coatings.



Typical dispersion of the refractive index for the indicated deposition conditions.

Scandium oxides

- Hard and durable films
- > Intermediate high refractive index material for AR and filters
- > High laser damage resistance
- Adhesion promoter

Film properties

Refractive index at 550 nm

- on unheated substrates/no IAD
- on unheated substrates/with IAD
- on heated substrates, T_s = 270 °C

Range of transparency

230 nm - ca. 12.0 µm Lower limit can vary in the range of 220 - 350 nm dependent on

~ 1.76 - 1.88

~ 1.80 - 1.95

~ 1.82 - 1.92

Tensile

the deposition conditions MIL-C-675 B/C passed

Tunable type and magnitude

Environmental Stability

on unheated substrates/no IAD

on unheated substrates/with IAD

on heated substrates, T_s ≥ 270 - 300 °C

Tensile Large spectral range of transmission and high laser damage threshold.

AR, HR, Filters for DUV (248, 355 nm), adhesion promoter for UV- and IR.

Application Guidelines

Characteristics of starting material

Availability as scandium oxide Sc₂O₃ in different purity grades.

Chemical formula Sc₂O₃ White Color Density g/cm³ ~ 3.9 Melting point °C ~ 2400

Granulate (recommanded), tablets Delivery form

Evaporation technique

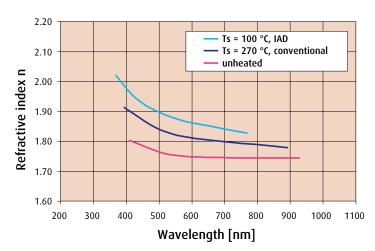
Scandium oxide is mostly evaporated by reactive e-beam evaporation from a Cu-crucible with Mo- or graphite liner. Scandium oxide Sc₂O₃ melts only superficially and predominantly sublimes. Therefore it requires a very uniform beam pattern and/or rotating crucible to avoid craters and uniformity

For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Deposition occurs typically at O_2 pressures of 2 – 4 x 10^{-4} mbar (or equivalent O₂ flow). Typical deposition in all sizes of coating systems involves rates of 0.2 - 0.5 nm/s. The tendency to heterogeneity can be counteracted using IAD.

Application fields

AR and multilayer coatings (dielectric mirrors, dichroics, narrowband filters, polarizers, beamsplitters) for DUV (> 230 nm), VIS and IR spectral range for precision optics and laser coatings. Potential adhesion promoter.



Typical dispersion of the refractive index for the indicated deposition conditions.

Yttrium oxides

- > Intermediate high refractive index material with small optical dispersion
- > Wide spectral range from near UV to mid-wave IR
- Adhesion promoter

Film properties

Refractive index at 550 nm

) on unheated substrates/no IAD 1.78 – 1.85) on unheated substrates/with IAD 1.80 – 1.90) on heated substrates, T_s = 300 °C 1.82 – 1.85

Range of transparency $\sim 250 \text{ nm} - 12.0 \text{ }\mu\text{m}$ Environmental Stability MIL-C-675 B/C passed

Stress

without IAD Tensile

on unheated substrates/with IAD

Tunable type and magnitude

Regardless of the starting material composition, low-absorbing yttria films are of the composition Y_2O_3 . Y_2O_3 films have an intermediately high refractive index with a small dispersion.

Such films are hard, durable and well-adhering and they can be used in AR and multilayer coatings – along with thin layers of SiO_2 or high index materials or as protective coatings.

Films of yttrium oxide of only several nanometers thickness are a good adhesion promoter for a number of oxides, sulfides and fluorides on mineral glasses and IR substrate materials.

Application Guidelines

Characteristics of starting material

Availability as yttrium oxide Y_2O_3 or $Y_2O_{3\cdot x}$ (with minor deficiency x of oxygen).

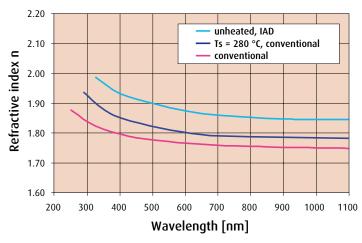
Evaporation technique

Yttrium oxide is mostly evaporated by reactive e-beam evaporation from a Cu-crucible with Mo-liner. Deposition from W-boats has also been reported. Yttrium oxide melts only superficially and predominantly sublimes. Therefore it requires a very uniform beam pattern and or rotating crucible to avoid craters and uniformity problems. For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Deposition occurs typically at O_2 pressures of $8.0 \times 10^{-5} - 4 \times 10^{-4}$ mbar (or equivalent O_2 flow). Typical deposition in all sizes of coating systems involves rates of 0.2 - 1.5 nm/s. The tendency to heterogeneity can be counteracted using IAD.

Application fields

AR coatings and multilayer coatings for near-UV, VIS and IR spectral range for precision optics and laser coatings. Protective coating on metal mirrors. Potential use for coatings on plastics. Optical function and adhesion promoter.



Typical dispersion of the refractive index for the indicated deposition conditions.

Magnesium oxides

- Hard and durable films
- Intermediate refractive index
- > Adhesion promotor

Film properties

Refractive index at 550 nm

on unheated substrates/no IAD 1.65 - 1.70 on heated substrates, T_s = 300 °C 1.70 - 1.74

Range of transparency 200 nm - 8.0 μm **Environmental Stability** MIL-C-675 B/C passed

Stress

> without IAD Compressive

on unheated substrates/with IAD Compressive with tunable

magnitude

Magnesium oxide films are hard and durable.

They have an intermediate refractive index and a wide range of transmission that enable their use in coating application from DUV to

Magnesium oxide films facilitate adhesion for a number of oxides and fluorides on mineral glasses and typical IR substrates.

Application Guidelines

Characteristics of starting material

Availability as magnesium oxide MgO.

Chemical formula Mg0

Color White or glassy transparent

Density 3.6 Melting point °C 2640

Tablets, granulate Delivery form

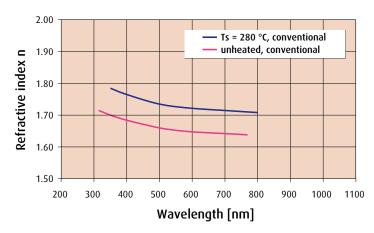
Evaporation technique

Magnesium oxide can only be evaporated by reactive e-beam evaporation. It sublimes completely and does not show any reduction in the crucible. For the intended variation of refractive index and film stress, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Deposition occurs typically at 0_2 pressures of 1 – 3 x 10^{-4} mbar (or equivalent 0, flow). Typical deposition in all sizes of coating systems involves rates of 0.2 – 0.5 nm/s. The tendency to heterogeneity can partly be counteracted using IAD.

Application fields

AR coatings for precision optics and laser coatings in DUV (> 200 nm), VIS and IR spectral range. Adhesion promoter.



Typical dispersion of the refractive index for the indicated deposition conditions.

Aluminium oxides

- Only high refractive index material for DUV
- Medium index material for VIS and IR spectral range
- Good laser damage resistance 193 1064 nm

Film properties

Refractive index at 550 nm

on unheated substrates/no IAD

on unheated substrates/with IAD

on heated substrates, T_s = 300 °C

Range of transparency

Environmental Stability

Stress

> without IAD

on unheated substrates/with IAD

1.60

1.63 - 1.68

1.63

> 190 (193) nm - ca. 7.0 µm

MIL-C-675 B/C passed

Tensile Tensile

Application Guidelines

Characteristics of starting material

Availability as aluminium oxide Al₂O₃.

Chemical formula Al₂O₃

Color White or glassy transparent

Density ~ 4.0

Melting point °C 2046

Delivery form Granulate (white and glassy), tablets (white)

Evaporation technique

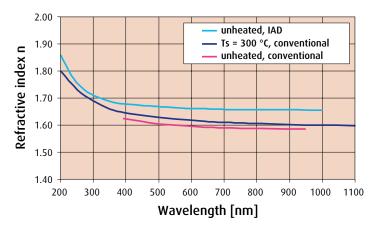
Aluminium oxides are mostly evaporated by reactive e-beam evaporation from a Cu-crucible with a small Mo-liner.

For the intended variation of refractive index, substrate temperature, oxygen pressure or flow, deposition rate and the parameters of ion assistance can be employed.

Deposition occurs typically at O_2 pressures of $1 - 2 \times 10^{-4}$ mbar (or equivalent O_2 flow). Typical deposition in all sizes of coating systems involves rates 0.25 - 0.5 nm/s.

Application fields

AR and multilayer coatings (dielectric mirrors, dichroics, narrowband filters, polarizers, beamsplitters) for DUV (> 190 nm), VIS and midwave IR spectral range for precision optics and laser coatings. Use for coatings on lithographic equipment (≥ 193 nm) and for coatings on plastics.



Typical dispersion of the refractive index for the indicated deposition conditions.

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